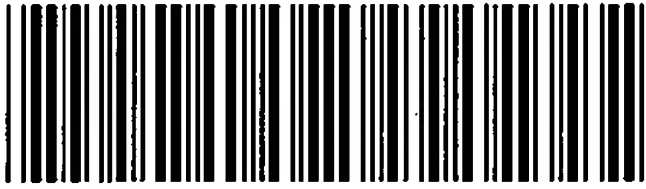


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/623,821	HE ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Lee S. Cohen	3739	

SEARCHED			
Class	Subclass	Date	Examiner
600	378	3/13/2007	LSC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	3/13/2007	LSC